
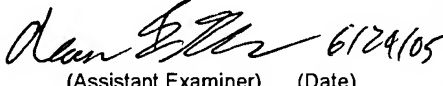
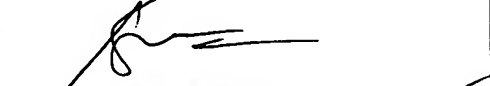



<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/614,864	INOUE, YASUO	
	Examiner	Art Unit	
	Alan S. Chen	2182	

ISSUE CLASSIFICATION										
ORIGINAL					CROSS REFERENCE(S)					
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
710		2			710	8	36	72		
INTERNATIONAL CLASSIFICATION										
G	0	6	F	3/00						
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 (Assistant Examiner) (Date) 6/24/05		 <b>KIM HUYNH</b> PRIMARY EXAMINER (Primary Examiner) (Date) 7/5/05		Total Claims Allowed: 15	
 (Legal Instruments Examiner) (Date) 7/8/05				O.G. Print Claim(s) 1	O.G. Print Fig. 7

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input checked="" type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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